Power MOSFET

20 V, 7.2 A, N-Channel ChipFET™

Features

- Low R_{DS(on)} for Higher Efficiency
- Logic Level Gate Drive
- Miniature ChipFET Surface Mount Package Saves Board Space
- Pb-Free Package is Available

Applications

Power Management in Portable and Battery-Powered Products; i.e.,
 Cellular and Cordless Telephones and PCMCIA Cards

MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

- ()				
Rating	Symbol	5 Secs	Steady State	Unit
Drain-Source Voltage	V _{DS}	20		V
Gate-Source Voltage	V_{GS}	±12		V
Continuous Drain Current $(T_J = 150^{\circ}C) \text{ (Note 1)}$ $T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	Ι _D	7.2 5.2	5.2 3.8	A
Pulsed Drain Current	I _{DM}	±20		Α
Continuous Source Current (Diode Conduction) (Note 1)	I _S	7.2	5.2	Α
Maximum Power Dissipation (Note 1) T _A = 25°C T _A = 85°C	P _D	2.5 1.3	1.3 0.7	W
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to +150		°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

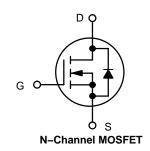
 Surface Mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).



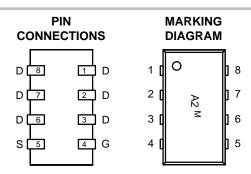
ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX
20 V	25 mΩ @ 4.5 V	7.2 A







A2 = Specific Device Code M = Month Code

ORDERING INFORMATION

Device	Package	Shipping [†]
NTHS5404T1	ChipFET	3000/Tape & Reel
NTHS5404T1G	ChipFET (Pb-Free)	3000/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Тур	Max	Unit
Maximum Junction–to–Ambient (Note 2) t ≤ 5 sec Steady State	$R_{ hetaJA}$	40 80	50 95	°C/W
Maximum Junction-to-Foot (Drain) Steady State	$R_{ hetaJF}$	15	20	°C/W

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Тур	Max	Unit
Static			-	-	•	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.6	_	_	V
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	-	-	±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 16 V, V _{GS} = 0 V	-	-	1.0	μΑ
		$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V},$ $T_{J} = 85^{\circ}\text{C}$	-	_	5.0	
On-State Drain Current (Note 3)	I _{D(on)}	$V_{DS} \ge 5.0 \text{ V}, V_{GS} = 4.5 \text{ V}$	20	-	_	Α
Drain-Source On-State Resistance (Note 3)	r _{DS(on)}	V _{GS} = 4.5 V, I _D = 5.2 A	-	0.025	0.030	Ω
		$V_{GS} = 2.5 \text{ V}, I_D = 4.3 \text{ A}$	-	0.038	0.045	1
Forward Transconductance (Note 3)	9fs	V _{DS} = 10 V, I _D = 5.2 A	-	20	-	S
Dynamic (Note 4)						-
Total Gate Charge	Q_{G}		-	12	18	nC
Gate-Source Charge	Q_{GS}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V},$ $I_{D} = 5.2 \text{ A}$	-	2.4	_	
Gate-Drain Charge	Q_{GD}	J -	-	3.2	_	
Turn-On Delay Time	t _{d(on)}		-	8.0	15	ns
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_{L} = 10 \Omega$	-	7.0	15	1
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1.0 \text{ A}, V_{GEN} = 4.5 \text{ V},$ $R_G = 6 \Omega$	-	50	60	1
Fall Time	t _f		_	28	40	1
DRAIN-SOURCE DIODE CHARACTERISTIC	s		-	-	•	
Forward Diode Voltage (Note 3)	V_{SD}	$V_{GS} = 0 \text{ V, } I_S = 5.2 \text{ A}$	-	0.8	1.2	V
Reverse Recovery Time	t _{rr}		-	20.9	_	ns
Charge Time	t _a	$V_{GS} = 0 \text{ V, } I_{S} = 5.2 \text{ A,}$	-	10.2	_	1
Discharge Time	t _b	$di_S/dt = 100 A/\mu s$	_	10.6	-	1
Reverse Recovery Time	Q_{rr}		_	11	_	nC

- Surface Mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
 Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Guaranteed by design, not subject to production testing.

TYPICAL ELECTRICAL CHARACTERISTICS

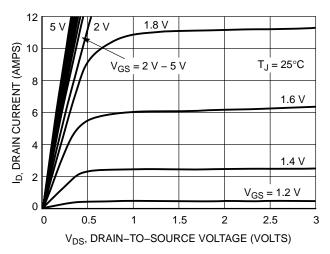


Figure 1. On-Region Characteristics

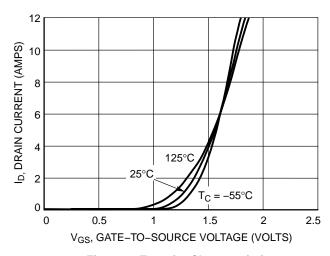


Figure 2. Transfer Characteristics

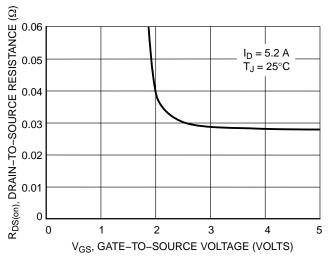


Figure 3. On–Resistance versus Gate–to–Source Voltage

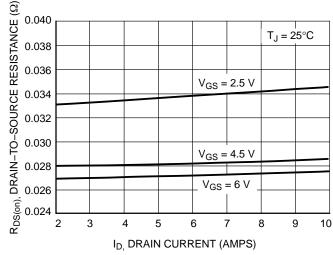


Figure 4. On-Resistance versus Drain Current and Gate Voltage

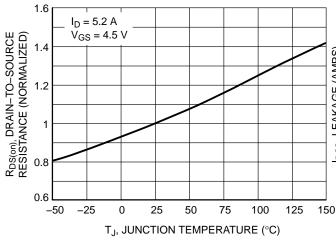


Figure 5. On–Resistance Variation with Temperature

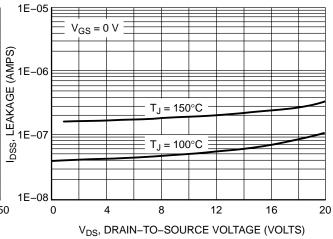
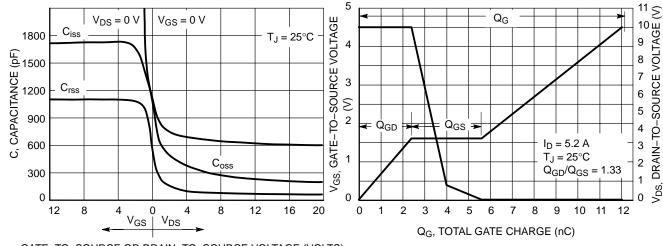


Figure 6. Drain-to-Source Leakage Current versus Voltage

TYPICAL ELECTRICAL CHARACTERISTICS



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

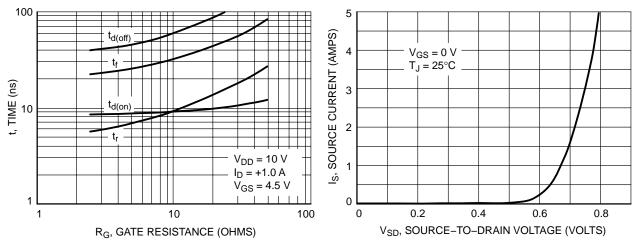


Figure 9. Resistive Switching Time Variation versus Gate Resistance

Figure 10. Diode Forward Voltage versus Current

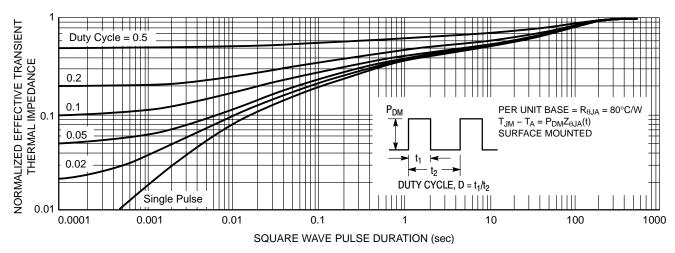
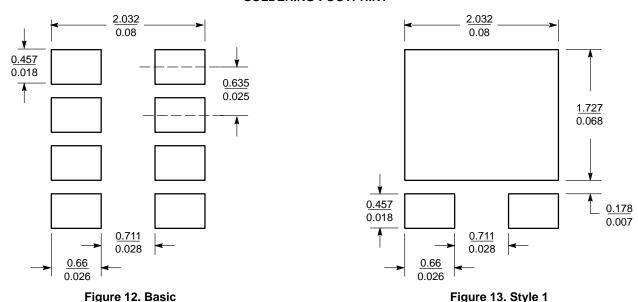


Figure 11. Normalized Thermal Transient Impedance, Junction-to-Ambient

SOLDERING FOOTPRINT*



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

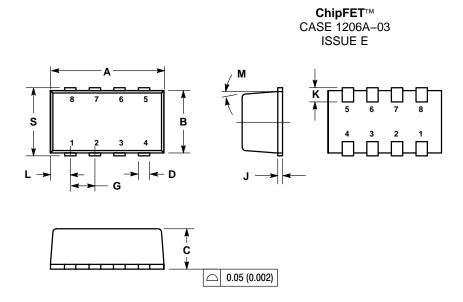
BASIC PAD PATTERNS

The basic pad layout with dimensions is shown in Figure 12. This is sufficient for low power dissipation MOSFET applications, but power semiconductor performance requires a greater copper pad area, particularly for the drain leads.

The minimum recommended pad pattern shown in Figure 13 improves the thermal area of the drain connections (pins 1, 2, 3, 6, 7, 8) while remaining within the

confines of the basic footprint. The drain copper area is 0.0054 sq. in. (or 3.51 sq. mm). This will assist the power dissipation path away from the device (through the copper lead–frame) and into the board and exterior chassis (if applicable) for the single device. The addition of a further copper area and/or the addition of vias to other board layers will enhance the performance still further.

PACKAGE DIMENSIONS



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER.
- MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE
- LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM
- DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE
- 6. NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.
- 1206A-01 AND 1206A-02 OBSOLETE. NEW STANDARD IS 1206A-03.

	MILLIMETERS		INC	HES		
DIM	MIN	MAX	MIN	MAX		
Α	2.95	3.10	0.116	0.122		
В	1.55	1.70	0.061	0.067		
С	1.00	1.10	0.039	0.043		
D	0.25	0.35	0.010	0.014		
G	0.65 BSC		0.02	0.025 BSC		
J	0.10	0.20	0.004	0.008		
K	0.28	0.42	0.011	0.017		
L	0.55 BSC		0.02	2 BSC		
M	5 °	5° NOM		5° NOM		
S	1.80	2.00	0.072	0.080		

STYLE 1: PIN 1. DRAIN

- 2. DRAIN 3. DRAIN
- 4. GATE 5. SOURCE
- 6. DRAIN
- 7. DRAIN
- 8. DRAIN

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